Notice of References Cited Application/Control No. 10/720,540 Examiner David Buttner Applicant(s)/Patent Under Reexamination HAYASHI ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,786,839	09-2004	Hayashi et al.	473/377
*	В	US-6,774,187	08-2004	Voorheis et al.	525/193
*	С	US-6,747,100	06-2004	Ichikawa et al.	525/440
*	D	US-6,458,892	10-2002	Rajagopalan et al.	525/92C
*	Ε	US-6,063,859	05-2000	Yamamoto et al.	524/590
*	F	US-2001/0055998	12-2001	Watanabe, Hideo	473/383
*	G	US-6,194,505	02-2001	Sone et al.	524/432
	н	US-			
	ì	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-2002336378	11-2002	JP	Ichikawa	
	0	EP-908199	04-1999	EP	Yamagishi	
	Р			-		
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	υ	THAIN, Science and Golf IV; July 2002; page 319-327			
	٧				
	w				
	x	is reference is not being furnished with this Office action (See MREP & 707.08(a).)			

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.